

<b>Notice of References Cited</b>	Application/Control No. 10/002,978	Applicant(s)/Patent Under Reexamination HSIEH ET AL.	
	Examiner Thao X Le	Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,163,050	12-2000	Hisatomi et al.	257/314
	B	US-6,358,864	03-2002	Chang et al.	438/261
	C	US-5,714,399	02-1998	Hisatomi et al.	438/261
	D	US-2002/0006706	09-1999	NISHIDA et al.	438/299
	E	US-2002/0048969	10-2001	Suzuki et al.	438/778
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.